

Notice of References Cited	Application/Control No. 10/800,420	Applicant(s)/Patent Under Reexamination KRAFT, RAYMOND H.	
	Examiner JOHN Wahnkyo LEE	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,091,972 A	02-1992	Kwon et al.	382/277
*	B	US-6,178,272 B1	01-2001	Segman, Yosef	382/298
*	C	US-6,340,114 B1	01-2002	Correa et al.	235/462.22
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Brandle et al., "Automatic Grid Fitting for Genetic Spot Array Images Containing Guide Spots," Spetmeber 1999, Springer Verlag, pages 357-366
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.